Search	Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/050,691	MIL'SHTEIN ET AL.
Examiner	Art Unit
Sheela C. Chawan	2625

SEARCHED				
Class	Subclass	Date	Examiner	
	- **			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
382	115,232	5/23/2005	scc	
382	278	5/23/2005	scc	
340	5.83	5/23/2005	scc	
283	68	5/23/05	sce	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	. DATE	EXMR	
US-PGPUB; USPAT;EPO;JPO;DERWENT;IBM- TDB.	5/23/2005	SCC	
IEEE.	5/23/2005	scc	
UP DATE THE SEARCH.	5/23/2005	scc	